Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/036,922	FECHER ET AL.
Examiner	Art Unit
Dmitry Levitan	2616

SEARCHED				
Class	Subclass	Date	Examiner	
370	357 360 366			
379	32.01		DL	
	33	1-/2	6/06	
455	455-	-/ 3/	/	
	457			
709	227			
	22,2			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	 			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
IEEE, EAST	5/26/00	5 DC
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